

INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

ATTY DOCKET NO.

12088/019001

APPLICATION NO.

107500317

APPLICANT(S)

Shinichi KAWASKI, et al.

Rec'd PCT/PTO 28 JUN 2004

FILING DATE

[Herewith]

GROUP ART UNIT

1703

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	A1	6,429,400 B1	08/06/2002	Sawada et al.	219	121.52	Sept. 22, 2000

U.S. PATENT APPLICATION PUBLICATIONS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
(B)	A2	3-219082	09/26/1991	Japan	C23C	16/50		✓
	A3	2002-158219	05/31/2002	Japan	H01L	21/31		✓
	A4	2002-80970	03/22/2002	Japan	C23C	16/509		✓
	A5	2000-178744	06/27/2000	Japan	C23C	16/50		✓
↓	65	7-29827	01/31/1995	Japan	H01L	21/205		✓

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

h	A7	Patent Abstracts of Japan, publication no. 11-236676, publication date August 31, 1999 (1 page)
m	A8	Patent Abstracts of Japan, publication no. 05-226258, publication date September 3, 1993 (1 page)

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

ATTY DOCKET NO.
12088/019001

APPLICATION NO.
107500317

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DT11 Rec'd DIST/PTO 28 JUN 2003

GROUP PART

1763

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

U.S. PATENT APPLICATION PUBLICATIONS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
46	B1	2003-249492	09/05/2003	Japan	H01L	21/31		✓
	B2	11-236676	08/31/1999	Japan	C23C	16/50		✓
	B3	5-226258	09/03/1993	Japan	H01L	21/205		✓
	B4	11-251304 **same as A1**	09/17/1999	Japan	H01L	21/3065		✓
✓	B5	3-248415	11/06/1991	Japan	H01L	21/205		✓

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

4	B6	Patent Abstracts of Japan, publication no. 11-251304, publication date September 17, 1999 (1 page)
	B7	Patent Abstracts of Japan, publication no. 03-248415, publication date November 6, 1991 (1 page)

EXAMINER

DATE CONSIDERED

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PTO/SB/08a/b (07-05)

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Substitute for form 1449A/B/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)				Complete if Known	
				Application Number	10/500,317-Conf. #9863
				Filing Date	June 28, 2004
				First Named Inventor	Shinichi Kawasaki
				Art Unit	1763
				Examiner Name	Not Yet Assigned <i>BERV</i>
Sheet	1	of	1	Attorney Docket Number	12088/019001

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
<i>NY</i>	AA*	US-20020007793-A1	08-24-2004	Sakai et al.	18/723E
<i>NY</i>	AB*	US-6,424,091	07-23-2002	Sawada et al.	315/111.81

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY			
NY	BA	JP-2000-188129	07-04-2000	Sekisui Chemical Co., Ltd.		
NY	BB	JP-2000-200697	07-18-2000	Matsushita Electric Works, Ltd.		

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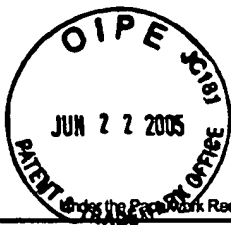
NON PATENT LITERATURE DOCUMENTS				
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²	
<i>NY</i>	CA	Patent Abstracts of Japan, Publication No. 2000-188199 dated 07/04/2000 by Sekisui Chem Co. Ltd., 2 pages.		
	CB	Copy of Japanese Office Action dated January 17, 2006		
	CC	Bardos, et al. Radio frequency plasma jet applied to coating of internal walls of narrow tubes; Journal of Vacuum Science & Technology A, Vol. 11, August 1993		
<i>NY</i>	CD	Concise Explanation of Relevance of JP 2000-188199		

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¹ Applicant's unique citation designation number (optional). ² Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature	<i>[Signature]</i>	Date Considered	8/10/06
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143303



PTO/SB/08a/b (08-03)
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Substitute for form 1449A/B/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)		Complete if Known			
		Application Number	10/500,317-Conf. #9863		
		Filing Date	June 28, 2004		
		First Named Inventor	Shinichi Kawasaki		
		Art Unit	2812 1763		
		Examiner Name	Not Yet Assigned ZERVIGN		
Sheet	1	of	1	Attorney Docket Number	12088/019001

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T ⁶
		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)				
M	BA	JP-2002-237480	08-23-2002	Sekisui Chem Co Ltd		
	BB	JP-2000-349051	12-15-2000	Seiko Epson Corp		
	BC	JP-9-232293	09-05-1997	Seiko Epson Corp		
V	BD	JP-9-246705	09-19-1997	Seiko Epson Corp		

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NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T ²
B	CA	Patent Abstracts of Japan, Publication No. 2002-237480, Publication Date 08/23/2002, 1 page			
	CB	Patent Abstracts of Japan, Publication No. 2000-349051, Publication Date 12/15/2000, 1 page			
	CC	Patent Abstracts of Japan, Publication No. 09/232293, Publication Date 09/05/1997, 1 page			
	CD	Patent Abstracts of Japan, Publication No. 09-246705, Publication Date 09/19/1997, 1 page			
V	CE	Notification of Examiner's Reasons of Rejection in Japanese Patent Application No. 2002-294125 dated 03/22/2005			

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¹ Applicant's unique citation designation number (optional). ² Applicant is to place a check mark here if English language Translation is attached.

Examiner Signature		Date Considered	8/10/06
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